Special Issue

Advances in Magnetic Resonance Imaging (MRI)

Message from the Guest Editor

This Special Issue presents advances in magnetic resonance imaging for clinicians and researchers. Magnetic resonance imaging, along with related technologies, have been continuously improved to provide diagnostic accuracy and various medical applications. Recent advances, including 3-dimensional modeling and segmentation using artificial intelligence, will enhance the utility of magnetic resonance imaging in numerous fields. Interested radiologists, technicians, doctors, and researchers may contribute their novel techniques and findings to enrich their colleagues. Both hardware and software can be the focus for the papers, as long as it adds new knowledge to the field. This Special Issue might provide a forum for academic discussion among the peer researchers. Keywords:

- magnetic resonance imaging
- medical imaging
- diagnosis
- radiology
- 3-dimensional modeling
- segmentation

Guest Editor

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Deadline for manuscript submissions

closed (20 July 2024)



Applied Sciences

an Open Access Journal by MDPI

Impact Factor 2.5 CiteScore 5.5



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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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